

Impact of defects on percolation in random sequential adsorption of linear k -mers on square lattice

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The effect of defects on the percolation of linear k -mers (particles occupying k adjacent sites) on a square lattice is studied by means of Monte Carlo simulation. The k -mers are deposited using a random sequential adsorption mechanism. Two models, L_d and K_d , are analyzed. In the L_d model, it is assumed that the initial square lattice is non-ideal and some fraction of sites, d , is occupied by non-conducting point defects (impurities). In the K_d model, the initial square lattice is perfect. However, it is assumed that some fraction of the sites in the k -mers, d , consists of defects, i.e., are non-conducting. The length of the k -mers, k , varies from 2 to 256. Periodic boundary conditions are applied to the square lattice. The dependencies of the percolation threshold concentration of the conducting sites, p_c , vs the concentration of defects, d , were analyzed for different values of k . Above some critical concentration of defects, d_m , percolation is blocked in both models, even at the jamming concentration of k -mers. For long k -mers, the values of d_m are well fitted by the functions $d_m \propto k_m^{-\alpha} - k^{-\alpha}$ ($\alpha = 1.28 \pm 0.01$, $k_m = 5900 \pm 500$) and $d_m \propto \log(k_m/k)$ ($k_m = 4700 \pm 1000$), for the L_d and K_d models, respectively. Thus, our estimation indicates that the percolation of k -mers on a square lattice is impossible even for a lattice without any defects if $k \gtrsim 6 \times 10^3$.

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I. INTRODUCTION

The adsorption of large particles such as colloids, proteins or nanotubes onto substrates can be treated and studied as random sequential adsorption (RSA) [1]. In RSA, objects randomly deposit onto the substrate; this process is irreversible, and the newly placed objects cannot overlap or pass through the previously deposited ones (for details see, e.g. a review by Evans [1]). Very often, irreversible RSA, without detachment or diffusion is considered. If the concentration of the deposited objects is large enough they form a path from one side of the system to its opposite side. Below this concentration, a spanning path does not exist; while above it, there exists a spanning component of the system size order. This concentration is denoted as the percolation threshold [2]. By placing objects at random onto a surface, but adsorbing only those that do not overlap previously adsorbed objects, one will finally reach a jamming limit beyond which no more objects can be adsorbed [1] (see an example of a jamming state in Figure 1a).

One of the simplest examples of a substrate is a square

lattice. A simple but very attractive instance of the type of object being adsorbed is a stiff rod, also denoted as stiff-chain or stick [3], line segment [4], rigid rod, needle [5], linear k -mer, etc. Here k means the length of the object. For uniformity, hereinafter we will use the term k -mer.

Many important findings regarding percolation and jamming of completely disordered k -mers [3–8] or partially aligned k -mers [9–12] have been reported over the last two decades.

Beckleheimer and Pandey found [3] that the percolation threshold decreases if the length of the sticks increases as

$$p_c(k) \sim k^{-1/2},$$

where k is the stiff-chain (stick) length. k varies up to 20. The jamming coverage decreases with the chain-length.

Leroyer and Pommiers investigated the percolation of line segments (linear k -mers with k values up to 40) and found that the percolation threshold initially decreases and then increases as the length of the segments increases [4].

Bonnier et al. studied the deposition of line segments with k values up to 512 on a two-dimensional square lattice and found that the jamming concentration goes down asymptotically to 0.660 ± 0.002 as the length of the rods increases [6].

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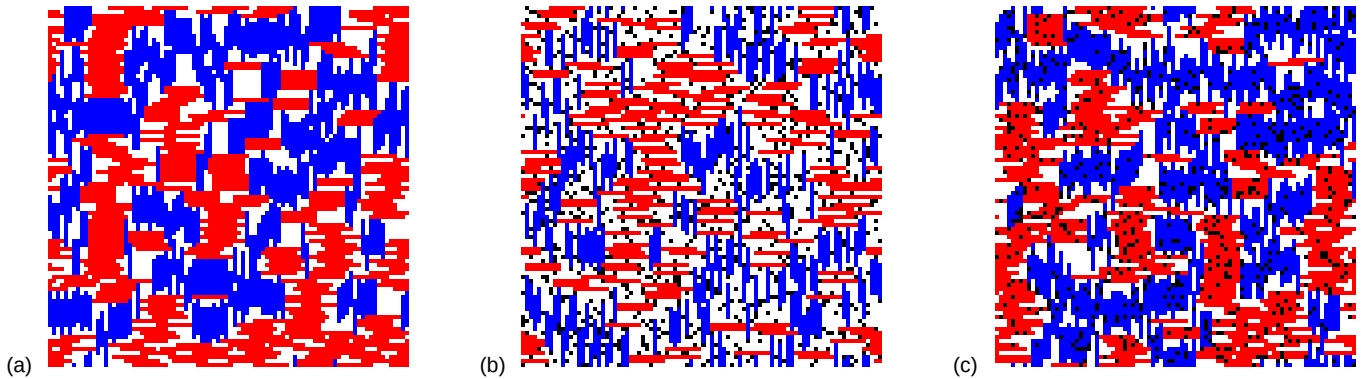


FIG. 1. Jamming states: (a) a perfect lattice filled with defect-free linear k -mers, (b) a lattice with defects filled with defect-free k -mers, (c) a perfect lattice filled with defective k -mers. Online: Horizontal k -mers are shown in red, vertical k -mers are shown in blue, empty sites are shown in white, defects are shown in black. Print: gray-scale. $k = 9$, fragment of a lattice 90×90 sites.

Vandewalle et al. explored the random sequential deposition of needles (linear k -mers with k values up to 10) and suggested that the percolation threshold and the jamming concentration decrease as the length of the rods increases

$$p = C \left(1 - \gamma \left(\frac{k-1}{k} \right)^2 \right)$$

both for percolation and for jamming. Here k is the length of the needles (sticks, rods, linear k -mers), while C and γ are the fitting parameters [5].

Kondrat and Pękalski (Ref. [7]) examined the percolation and jamming of linear segments on a square lattice (k up to 2000) and found that the percolation threshold, p_c , and the jamming concentration, p_j , initially decrease but then increase as the length of the rods increases

$$p_c/p_j \sim 0.50 + 0.13 \log_{10} k.$$

One can easily calculate $p_c = p_j$ if $k \approx 0.7 \times 10^4$.

Cornette et al. studied the percolation of linear segments of size k and k -mers of different structures (k varies up to 15) on a square lattice and reported that the percolation threshold exponentially decreases with the length of the rods [8]. The percolation threshold as a function of k for linear segments is fitted by

$$p_c(k) = p_c^* + \Omega \exp \left(-\frac{k}{\kappa} \right),$$

where the fitting parameters are $p_c^* = 0.461 \pm 0.001$, $\Omega = 0.197 \pm 0.02$, $\kappa = 2.775 \pm 0.02$.

Longone et al. [9] studied the deposition of aligned rigid rods of length k up to 12 and found that the percolation threshold for completely ordered deposition decreases if the length of the rods increases, which is similar to the case with disordered deposition [8].

Recently, jamming [10] and percolation [11] of linear k -mers have been intensively studied for values of k up to 512 for percolation and up to 256 for jamming. It

was demonstrated that the jamming concentration continuously decreases as the length of the k -mer increases. On the other hand, the percolation threshold initially decreases and then increases with increasing k . For completely disordered systems, a conjecture has been offered that percolation is impossible if k exceeds approximately 1.2×10^4 [11]. Direct verification of the conjecture is very time-consuming and problematic even with a high-performance computer. Less laborious indirect methods for testing the hypothesis would be very appealing. We should emphasize that the estimation in [11] has the same order as the estimation in [7], nevertheless the results for large values of k have rather large errors in both works.

However, the deposition of particles without defects onto a completely regular lattice would seem to be too idealized a model. In the real world, a substrate may be not perfect, i.e. initially, some impurities may be already present on the substrate. In most practical cases, the surfaces are chemically heterogeneous and contain defects [13]. In theoretical works, a lattice with impurities is sometimes treated as a diluted lattice [14]. Such a lattice is built by randomly selecting a fraction of the sites which are then considered forbidden for the succeeding deposition of any objects. A jamming state on a diluted square lattice is presented in Figure 1b. For uniformity within the rest of the text, we shall use the term 'defect' here and below.

The structure of elongated particles, e.g., carbon nanotubes, may also be highly heterogeneous due to their chemical functionalization; moreover, a length polydispersity may also be present [15].

In practice, both kinds of imperfection may occur, i.e. one has to consider the deposition of objects with defects onto a substrate with defects.

That is why the study of defective systems involving k -mers is very important and many previous works have been related to these problems.

The jamming and percolation of k -mers on disordered (or heterogeneous) substrates with defects (or impurities) has attracted great attention [14, 16–24]. A lattice with

defects is built by randomly selecting a fraction of insulating monomers [14, 21, 24] or k -mers [19, 20] which are considered forbidden for the succeeding deposition of any objects. The jamming limits p_j for the deposition of k -mers onto a one-dimensional line and a two-dimensional disordered square lattice were calculated using the Monte Carlo method [17]. Note that the total jamming coverage (i.e., the value of $p_j + d$) decreased when the concentration of impurities d increased and reached a minimum which depended on k [17, 18]. For the problem of k -mer deposition onto a square lattice, it has been established that, upon increasing d , the percolation threshold p_c grows up to a maximum value $p_c^m(d_m)$, and that there is no percolation above d_m [14, 21, 22].

Cornette et al. [14, 21] investigated, numerically, the percolation of polyatomic species with the presence of impurities on a square lattice with periodic boundary conditions. Both bond and site percolation problems were taken into consideration. Linear k -mers, as well as so-called SAW k -mers, i.e. segments of a self-avoiding walk, have been studied up to values of $k = 9$. A phase diagram where the critical concentration of impurities is plotted as a function of k has been proposed. The concentration of impurities at which percolation becomes impossible, even at jamming coverage, decreases rapidly with increasing values of k . This research suggests that there is a critical length, k , at which percolation is impossible even without impurities. This suggestion may be incorrect if the critical concentration of impurities decreases to zero asymptotically with increasing k . In principle, an investigation of the critical impurity concentration for large values of k might answer the question: ‘Is the percolation of long rods possible?’.

The goal of the present research is to investigate the effect of different sorts of defects on percolation and jamming in the random sequential adsorption of linear k -mers onto a square lattice. We analyzed and compared two different models. We investigated the RSA of (a) perfect linear k -mers onto a square lattice with previously placed non-conducting point defects (L_d model), and (b) linear k -mers with defects onto an ideal square lattice (K_d). The length of the k -mers, k , varied from 2 to 256, and periodic boundary conditions were applied. For each given value of k , we were looking for a critical concentration of defects, d_m , when percolation is possible only at the jamming concentration.

The main question to be answered for both systems, i.e., the ideal k -mers on a lattice with defects and for k -mers with defects on an ideal lattice, is the following: how do the percolation threshold and the jamming concentration vary with the length of the k -mers and the concentration of defects?

The rest of the paper is constructed as follows. In Section II we describe the technical details of our simulations. Section III presents our main findings. In Section IV, we summarize the results and conclude the paper.

II. DETAILS OF THE SIMULATION

We considered a discrete two-dimensional space (square lattice $L \times L$) with periodic boundary conditions, i.e. we considered the RSA on a torus. The deposited objects were linear k -mers (particles occupying k adjacent sites). An object can be deposited in two allowed perpendicular orientations (vertical or horizontal) with equal probabilities, i.e. we are considering isotropic deposition. The filling fraction of the lattice by k -mers is $f = Nk/L^2$, where N is the number of k -mers. Two different models with non-conducting point defects on the lattice (L_d model) and defects of the k -mers (K_d) are analyzed.

A. Ideal k -mers on a lattice with defects, L_d model

The lattice is assumed to be initially filled with point nonconducting defects at a given concentration d . Then the ideally conducting k -mers are deposited onto the substrate using RSA rules. We will denote this model as the L_d model for short. The filling fraction of the lattice, f , changes within $[0; p_j]$, where $p_j(d)$ is the jamming concentration at the given d . In this model all k -mers are conducting and the fraction of conducting sites, p , coincides with f , i.e., $p = f$.

The jamming state for the L_d model is presented in Figure 1b.

B. k -mers with defects on an ideal lattice, K_d model

In this model, ideal lattice is filled using k -mers with defects. We will denote this model as the K_d model for short. The k -mers with defects contain some fraction of non-conducting defects. Let the average fraction of defects per object be d . The filling fraction of the lattice, f , changes within $[0; p_j]$ where p_j is the jamming concentration for k -mers deposited on the ideal lattice. The jamming state for the K_d model is presented in Figure 1c. In this model the fraction of conducting sites is $p = f(1 - d)$ and the connectivity analysis is carried out by accounting only for the conducting particles. The percolation concentration is determined as $p_c = f_c(1 - d)$, where f_c is the critical filling fraction that corresponds to the formation of a spanning cluster of sites filled with conducting particles. At the jamming concentration, i.e., at $f = p_j$, percolation is observed when the concentration of defects is smaller than some maximum value, d_m . The percolation concentration for this case is $p_c^m = p_j(1 - d_m)$.

C. Common technical details

The lattice is filled to a given concentration and then checked for the presence of percolation cluster or not.

Spiral clusters are treated as being percolating (see details in [11]). In our simulation, a square lattice of size $L \times L$ sites was filled with k -mers until jamming coverage occurred. This was repeated 1000 times and the probability, R_L , for a cluster of k -mers wrapping the system was found. We used two criteria: criterion OR means there is a cluster wrapping the system either in a horizontal or vertical direction, criterion AND means there is a cluster wrapping the system in both directions simultaneously. The probability curves $R_L(p)$ and $R_L(d)$ have been fitted by the Boltzmann function

$$R_L(p) = 1 - \left(1 + \exp \left(\frac{p - p_c(L)}{\Delta p} \right) \right)^{-1}, \quad (1)$$

$$R_L(d) = \left(1 + \exp \left(\frac{d - d_c(L)}{\Delta d} \right) \right)^{-1}, \quad (2)$$

where $p_c(L)$, $d_c(L)$, Δp , and Δd are the fitting parameters. For examples of the analysis for the L_d model see Figure 2.

We used three different lattice sizes to perform a scaling analysis and to find the percolation threshold in the thermodynamic limit ($L \rightarrow \infty$) (see, e.g. [2])

$$p(L) - p_c(\infty) \sim L^{-1/\nu},$$

where ν is the universal critical exponent. For percolation in two dimensions $\nu = 4/3$ (see, e.g. [2]). A similar relation was used for assessing the critical concentration of defects in the thermodynamic limit.

Examples of scaling for the criterion AND (there is a wrapping cluster in both directions), and OR (there is a wrapping cluster either in the vertical or in the horizontal direction) are shown in Figures 3a (L_d model) and 3b (K_d model).

For $k \leq 32$, we used lattice sizes $L = 100k, 200k$, and $400k$ to perform the scaling analysis. We obtained $p_c(L)$ and $d_c(L)$ using the probability curves for the criterion AND. For $k = 64$, we used lattice sizes $L = 100k, 150k$, and $200k$ to save time. To ensure precision, we utilized the probabilities for both the criteria AND and OR for scaling. For $k = 128$ the lattice sizes $L = 75k, 100k$, and $125k$ and the probabilities for both the criteria AND and OR were used. Additionally, the critical concentrations of defects and objects were estimated using $R^* \approx 0.9$ ($R_L(p_c) = R^*$) [11].

To verify our program and method, we compared our results for the isotropic deposition with published numerical simulation results for short linear k -mers ($k \leq 9$) on a diluted square lattice (L_d model) [14, 21] (Figure 4)). The agreement of our results and the published data is very good.

III. RESULTS AND DISCUSSION

Figure 5 demonstrates how the percolation threshold and jamming concentration vary with the length of the

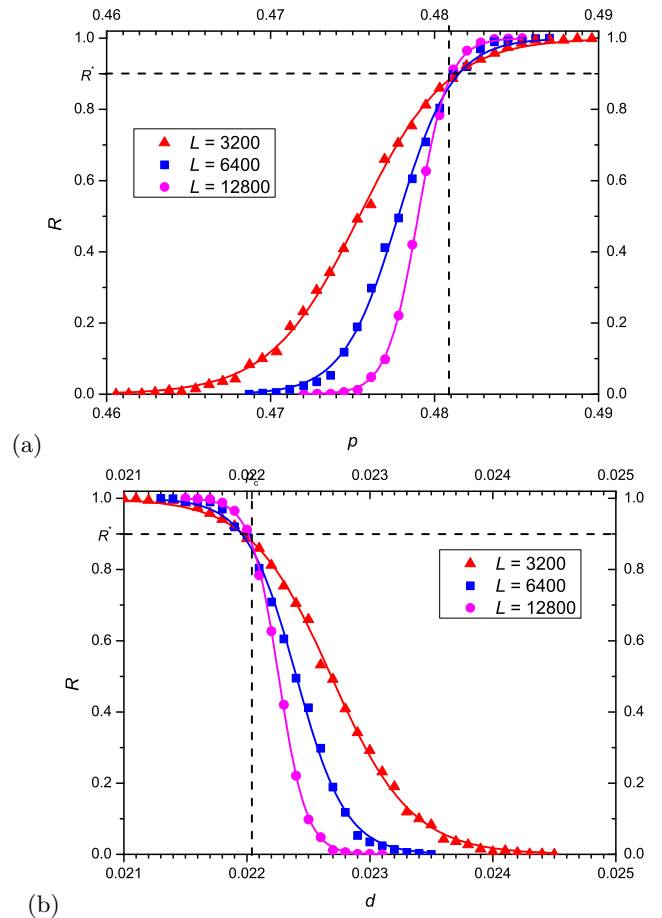


FIG. 2. Examples of probability curves for the L_d model for the concentration of objects (a) and defects (b). $k = 32$. Criterion AND is used. The statistical error is smaller than the marker size. The solid lines correspond to fitting functions (1) and (2). The vertical dashed lines correspond to p_c (a) and d_m (b). The horizontal dashed lines correspond to $R(p_c) = R^*$ (a) and $R(d_m) = R^*$.

perfect k -mers in the presence of defects on the substrate at a given concentration. The jamming concentration of k -mers decreases when the concentration of defects grows. The larger the value of k the more noticeable is the effect. By contrast, the percolation threshold is almost insensitive to the defect concentration.

Figure 6 presents the percolation threshold p_c vs the concentration of defects d for different values of k . Percolation is observed when the concentration of defects is smaller than a critical concentration of defects, d_m . In the L_d model, the percolation threshold is almost independent of the defect concentration up to $k \approx 10$ and has a maximum ($d \in [0, d_m]$) for larger values of k (Figure 6a). In contrast, the percolation threshold in the K_d model is rather sensitive to the defect concentration. It increases monotonically between $d = 0$ and $d = d_m$ for short k -mers ($k < 8$) but has a distinct maximum for longer objects ($k > 8$) (Figure 6b). The observed differences evidently reflect distinctions in the configurations

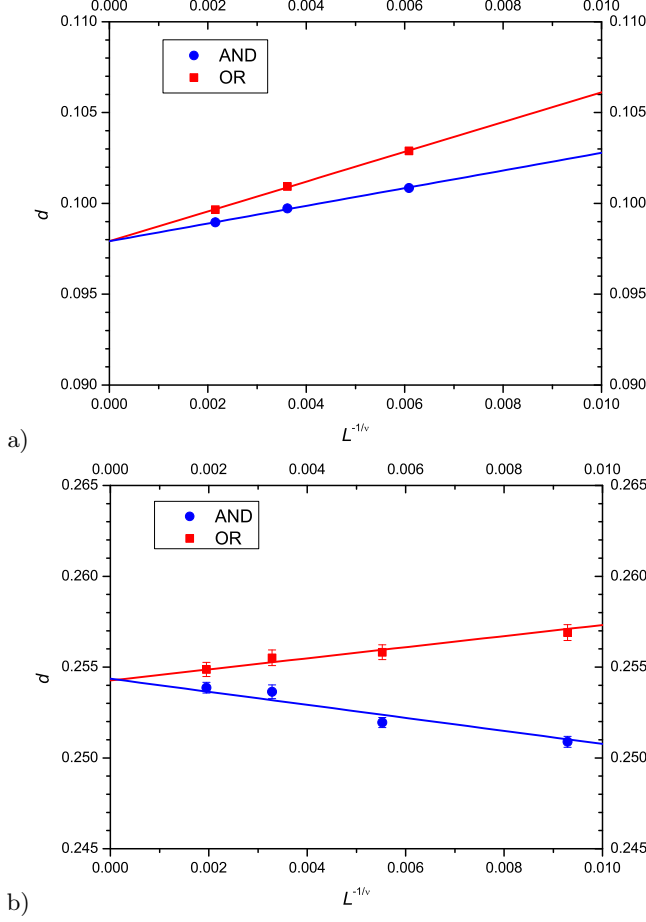


FIG. 3. A sample of scaling ($k = 9$) for the criterion AND (there is a wrapping cluster in both directions) (circles) and OR (there is a wrapping cluster either in the vertical or in the horizontal direction) (squares). d is the concentration of defects, L is the lattice size, ν is the critical exponent. (a) L_d model. The statistical error is smaller than the marker size. (b) K_d model.

of the k -mers for the two models studied. E.g., in the jammed state, the two models L_d and K_d produce rather different configurations of deposited k -mers. In the L_d model, the defects hinder the further deposition of the k -mers and the jammed state for this model (Figure 1a) is more sparse compared with the conventional jamming that is realized with the K_d model (Figure 1b).

A graphical representation (Figure 7) is more suitable for the analysis.

For the L_d model, the data are well fitted with a high coefficient of determination ($R^2 = 0.9999$) by the function

$$d_m = a \frac{k_m^\alpha - k^\alpha}{b + k^\alpha} \quad (3)$$

with $a = 0.006 \pm 0.002$, $\alpha = 1.28 \pm 0.01$, $b = 3.75 \pm 0.14$. The critical length of the k -mers, k_m , is approximately 5900 ± 500 .

For long k -mers in the limit of $k \rightarrow k_m$, Eq. 3 gives

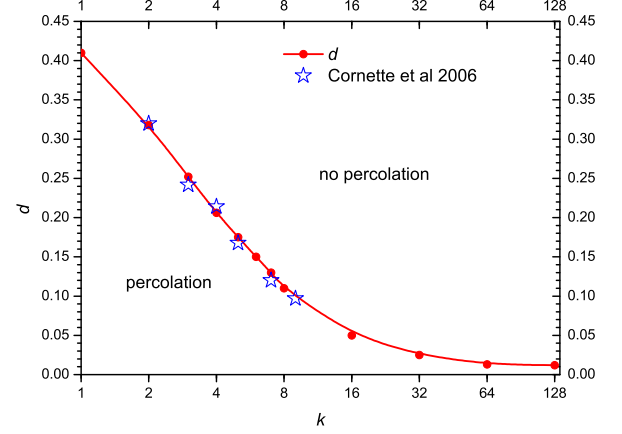


FIG. 4. Comparison of our results (circles) and the results obtained earlier [14, 21] (stars). d_m is the critical concentration of defects which blocks percolation even at jamming concentration. The error bars are smaller than the symbol size. The curve corresponds to our fitting function (3) (L_d model). The statistical error is smaller than the marker size.

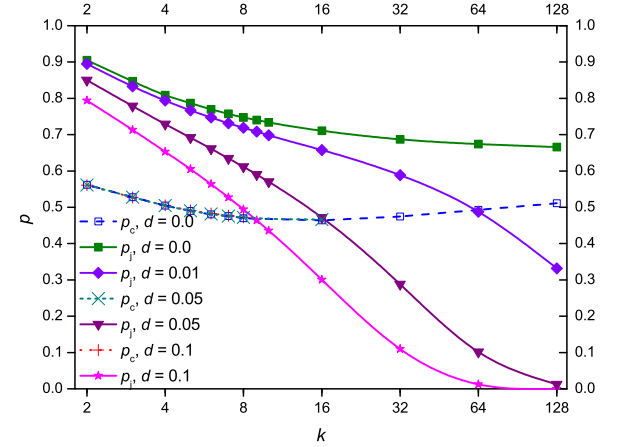


FIG. 5. Percolation threshold and jamming concentration vs length of k -mers for different defect concentrations. L_d model. The lines are a guide to the eye.

$d_m \propto k^{-\alpha}$ (see, Figure 7b).

On the other hand, for the K_d model, in the limit of large values of k the data are well fitted ($R^2 = 0.9998$) with the following function

$$d_m = a \log(k_m/k) \quad (4)$$

with $a = 0.103 \pm 0.006$, $k_m = 4700 \pm 1000$ (see, Figure 7c).

Note that the estimated critical lengths of k -mers are in close correspondence with the earlier estimations [7, 11].

Table I summarizes our results on the critical concentration of defects (d_m) at which percolation is possible only at jamming concentration (p_c^m) for the L_d and K_d models. The percolation thresholds for the ideal k -mers on an ideal square lattice are also presented for comparison.

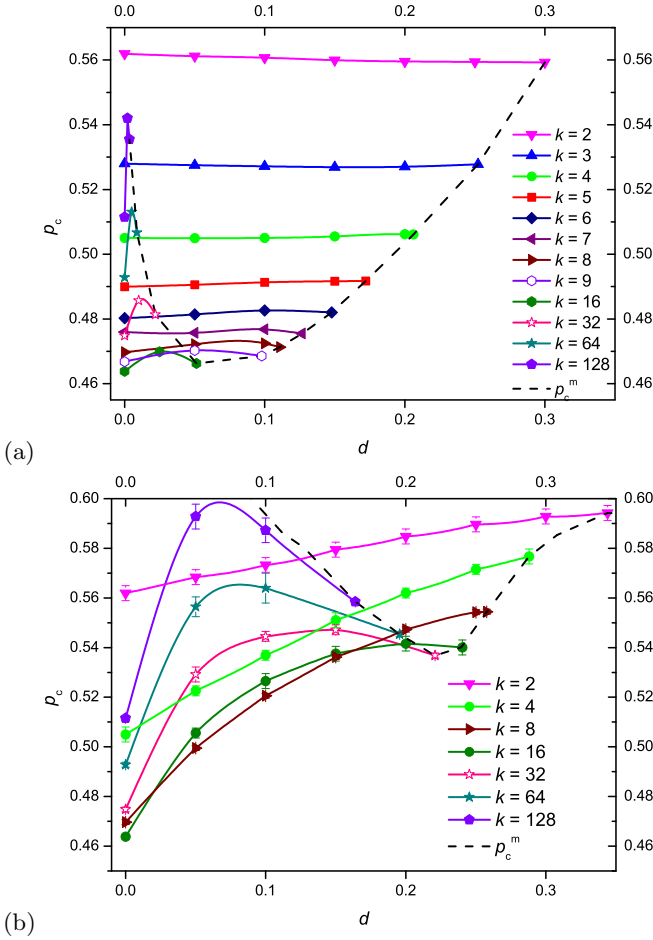


FIG. 6. Percolation threshold p_c vs concentration of defects, d , for different values of k . The solid lines are a guide to the eye. The dashed lines show dependencies $p_c(d_m)$, where d_m is a critical concentration of defects. (a) L_d model. The statistical error is smaller than the marker size. (b) K_d model.

IV. CONCLUSION

It is well known that extrapolation is less reliable than interpolation. Conjectures for the percolation threshold and jamming concentration tend towards constants as the length of the k -mers increases, based on the simulations for relatively short k -mers [3, 5, 6, 8, 9]. However, this conjecture seems to become invalid when considering the results of computer-based experiments with larger k -mers [4, 7, 11]. In any case, the percolation and jamming behavior of adsorbed layers produced by the deposition of very long k -mers ($k \gtrsim 10^3$) is still not particularly clear because the conclusions are based on results obtained for not very large objects then being extrapolated to represent very long objects. Direct simulation of the RSA for such large objects looks like a very time-consuming task and, to the best of our knowledge, has not yet been undertaken.

The results presented in this work give an indirect con-

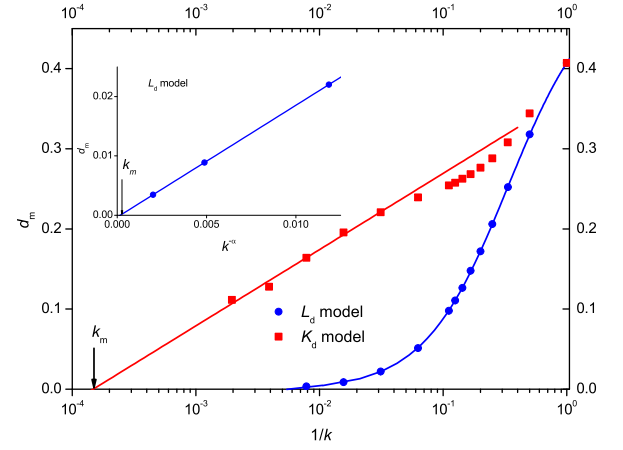


FIG. 7. Critical concentration of defects vs reciprocal length of k -mers. L_d and K_d models. The statistical error is smaller than the marker size. For the L_d model, the solid line corresponds to the fitting function (2). For the K_d model, the solid line corresponds to the linear fitting functions. Inset: Magnification of long k region for the L_d model.

TABLE I. Critical concentration of defects (d_m) at which percolation is possible only at the jamming concentration (p_c^m) and corresponding percolation threshold ($p_c(d=0)$) for linear k -mers. L_d and K_d models.

k	L_d model				K_d model	
	$p_c(d=0)$	$p_j(d=0)$	p_c^m	d_m	p_c^m	d_m
1	0.5927	1	0.5927	0.4073	0.5927	0.4073
2	0.5619	0.906	0.55930	0.31803	0.5619	0.3441
3	0.52797	0.846	0.52780	0.252200	0.538	0.308
4	0.5050	0.81	0.50614	0.20612	0.522	0.288
5	0.48997	0.7868	0.49176	0.17219	0.5103	0.2765
6	0.48026	0.7703	0.48205	0.14780	0.502	0.2683
7	0.47600	0.7579	0.47552	0.12656	0.4953	0.2626
8	0.4697	0.747	0.4713	0.11072	0.4892	0.2578
9	0.4668	0.7405	0.46855	0.09792	0.4861	0.2544
16	0.4638	0.71	0.46627	0.05136	0.4706	0.2394
32	0.4748	0.689	0.48094	0.02202	0.4681	0.2209
64	0.4928	0.678	0.50665	0.0089	0.4824	0.1956
128	0.5115	0.668	0.5355	0.0035	0.504	0.164
256	0.53	0.665			0.537	0.128

firmation of the conjecture that percolation of k -mers is impossible if the length exceeds a critical value. Our new estimation gives that critical length is a little bit less than the value published in earlier works [7, 11].

From a practical point of view, further consideration of the RSA of objects with defects onto a substrate with defects looks very attractive as a research project. Moreover, the deposition of the objects onto a substrate may, in fact, actually be not isotropic. We will report our results on this more realistic model in future papers.

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